

APR 08 2002

SHEET 1 OF 2

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

217954US0

SERIAL NO.

10/035,123

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takaharu et al.

FILING DATE

January 4, 2002

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MC	AA	6,184,288	2/6/01	Ninomiya et al.			
MC	AB	3,847,845	11/12/74	Renaro TADA, et al.			
MC	AC	5,118,743	6/2/92	Yonezu et al. (Equivalent to JP 64-66262)			
MC	AD	5,146,822	9/15/92	Noda et al. (equivalent to JP 3-61507)			
MC	AE	5,322,866	6/21/94	Mayer et al.			
	AF						
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	AN						

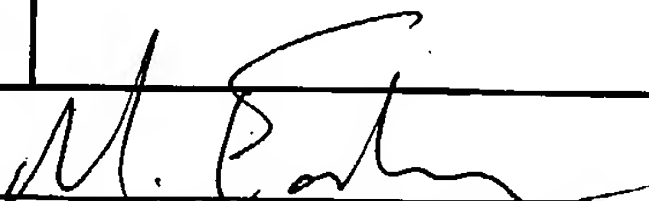
FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
MC	AO	JP 64-66262	9/7/87	JAPAN (equivalent to US 5,118,743)		x
MC	AP	JP 55012108 A	1/28/80	JAPAN (with English Abstract)		x
MC	AQ	JP 57034148 A	2/24/82	JAPAN (with English Abstract)		x
MC	AR	JP 3-61507	3/18/91	JAPAN (equivalent to US 5,146,822)		x
MC	AS	EP 0 892 006 A2	7/16/98	EUROPE	x	
MC	AT	JP 11058500 A	3/2/99	JAPAN (with English Abstract)		x
MC	AU	JP 11058501 A	3/2/99	JAPAN (with English Abstract)		x
MC	AV	WO99/05213	4/2/99	WIPO (equivalent to EP 0 930 339 A1)	x	

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

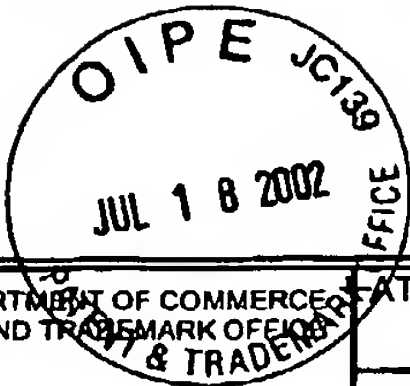
Examiner



Date Considered

29/Apr/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217954US0		SERIAL NO. 10/035,123	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takaharu KAWAHARA, et al.			
				FILING DATE January 4, 2002		GROUP 1731	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
MC	AO	1 179 546	02/13/2002	EUROPE			
MC	AP	1 072 616	01/31/2001	EUROPE			
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>M. E. [Signature]</i>					Date Considered <i>29/Apr/04</i>		
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